Analysis of ion-beam induced degradation of poly(vinylidene fluoride) and post-irradiation treatment for efficient track etching

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Ion-track membranes of poly(vinylidene fluoride) (PVDF), a type of fluoropolymer, could find wide applications due to its superior chemical and mechanical properties. In order to produce track-etched pores in PVDF films, a highly-concentrated alkaline solution with a strong oxidizing agent (e.g., KMnO₄) has mostly been used at a high temperature. Yet this provides irreversible chemical damage over the entire film including the nonirradiated part [1]. Thus, we have developed much milder etching conditions without any oxidant additives in the alkaline etching solution [2]. The goal of this work is to investigate the effect of post-irradiation treatment to pursue the possibility of accelerating the track etching rate. The discussion is given to this based on the detailed chemistry of heavy-ion-induced degradation, which was analyzed at the M-branch.

Commercially-available 25- μ m thick PVDF films were irradiated at room temperature with 450-MeV ¹²⁹Xe ions at the TIARA cyclotron of JAEA, and with 2.2-GeV ¹⁹⁷Au ions at the UNILAC. The irradiation at UNILAC was performed in the multi-purpose chamber of the M3 beamline equipped with a Fourier-transform infrared (FT-IR) transmission spectrometer and a quadrupole mass. analyzer. The FT-IR spectra and the residual gas data were recorded in-situ as a function of fluence up to 6×10¹¹ ions/cm². For the track-etching experiments, the irradiation at TIARA was performed at a lower fluence of 3×10⁷ ions/cm². The irradiated film was etched in a 9 mol/dm³ aqueous potassium hydroxide (KOH) solution at 80°C. The track etch rate was determined via measuring the breakthrough time ($T_{\rm B}$) in a conductometric etching cell.

The FT-IR analyses undoubtedly confirm that the irradiation efficiently produces C=C double bonds, both within and at the end of the main chain [3]. Main outgassing fragments were seen at mass-to-charge ratios (m/z) equal to or below 20. The most dominant peak appeared at m/z = 20 assigned to hydrogen fluoride (HF), which was predicted as degradation product for the formation of unsaturations in the main chain [4]. Additional large signals were located at m/z = 2, 18, and 19 from hydrogen (H₂), residual water (H₂O), and fluorine (F), respectively. Other masses are assigned to CH_x fragments from the degradation of hydrocarbons. Importantly, dehydrofluorination occurs very efficiently to produce the C=C double bonds.

Therefore, we finally consider how the C=C double bonds could be oxidized efficiently. When the oxidant coexists, they are readily converted to C=O groups with a high water wettability enabling faster attack by the etchant. We chose ozone as the oxidant for the pre-etching

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treatment. PVDF films irradiated with 450-MeV ¹²⁹Xe ions were exposed to ozonized O₂ for 6 h at room temperature. Figure 1 shows our preliminary conductometry results. The conductance values on the ordinate are not converted to an effective pore diameter, d_{eff} , because the measurement was intended to analyze $T_{\rm B}$ for samples with and without the ozone treatment. The breakthrough time $T_{\rm B}$ of the ozone-treated film is about seven times shorter than that of the untreated film. This clearly demonstrates that the pre-etching treatment with a gaseous oxidant greatly accelerated the track etching rate. The reason for this effect is possibly linked to a quick reaction between ozone and alkenes to yield products in which the double bond is cleaved, such as ketones and carboxylic acids. It should be emphasized that this post-irradiation treatment method was achieved by the feedback from our findings regarding the basic chemistry in the track, quite in contrast to the previous study on ozone-induced track sensitization of PET films [5].



Fig. 1: Measured conductance vs. etching time for PVDF films irradiated with 450-MeV 129 Xe ions (a) with and (b) without treatment with ozone gas before the etching.

- C. Daubresse, T. Sergent-Engelen, E. Ferain, Y.-J. Schneider, R. Legras, Nucl. Instr. Meth. B, 105 (1995) 126.
- [2] T. Yamaki, N. Nuryanthi, H. Koshikawa, M. Asano, S.Sawada, S. Hasegawa, Y. Maekawa, K.-O. Voss, C. Trautmann, R. Neumann, Trans. Mater. Res. Soc. Japan, 37 (2012) 223.
- [3] T. Yamaki, M. Asano, H. Koshikawa, Y. Maekawa, D. Severin, T. Seidl, C. Trautmann, GSI Scientific Report 2011 (2012) 420.
- [4] For example, A Le Bouëdec, N. Betz, S. Esnouf, A. Le Moël, Nucl. Instr. Meth. B, 151 (1999) 89.
- [5] T.E. Laricheva, A.A. Machula, V.K. Milinchuk, Colloid J.,66 (2004) 57.